Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/530,066	KAIN, ARON ZEV
Examiner	Art Unit
William Oen	2855

	SEARCHED		
Class	Subclass	Date	Examiner
73	146 146.5 715-728 753	11/22/2005	wo

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
Same as	Above	11/22/2005	wo	
	<u> </u>			

(INCLUDING SEA	I NOTES RCH STRATEGY)
	DATE	EXMR
EAST	11/22/2005	wo
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